Search Notes



10674159

Applicant(s)/Patent Under Reexamination

CHEN ET AL.

Examiner
Sean R McGarry

Art Unit

	,

SEARCHED							
Class	Subclass	Date	Examiner				

SEARCH NOTES			
Search Notes	Date	Examiner	
WEST, STN, STIC SEQ SRCH, INVENTOR SRCH, reviewed related	11/21/08	sm	
11/102,097, provisionals 60/414,457 60/446,377			

	INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20081121